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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/046,741	01/17/2002	Yoshinobu Ono	3885-0103P	2546
2292	7590 03/18/2004		EXAM	INER
BIRCH ST	EWART KOLASCH	MULPURI, SAVITRI		
PO BOX 74	17 URCH, VA 22040-074	ART UNIT	PAPER NUMBER	
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			DATE MAILED: 03/18/2004	

Please find below and/or attached an Office communication concerning this application or proceeding.

	Application No.	Applicant(s)			
	10/046,741	ONO ET AL.			
Office Action Summary	Examiner	Art Unit			
	Savitri Mulpuri	2812			
The MAILING DATE of this communication appeariod for Reply	opears on the cover sheet with the	correspondence address			
A SHORTENED STATUTORY PERIOD FOR REP THE MAILING DATE OF THIS COMMUNICATION - Extensions of time may be available under the provisions of 37 CFR 1 after SIX (6) MONTHS from the mailing date of this communication. - If the period for reply specified above is less than thirty (30) days, a re - If NO period for reply is specified above, the maximum statutory perior - Failure to reply within the set or extended period for reply will, by statu Any reply received by the Office later than three months after the mail earned patent term adjustment. See 37 CFR 1.704(b).	.136(a). In no event, however, may a reply be to oply within the statutory minimum of thirty (30) da d will apply and will expire SIX (6) MONTHS from the, cause the application to become ABANDON	imely filed sys will be considered timely. In the mailing date of this communication. ED (35 U.S.C. § 133).			
Status					
2a) ☐ This action is FINAL . 2b) ☐ The 3) ☐ Since this application is in condition for allow	Responsive to communication(s) filed on <u>09 March 2004</u> . This action is FINAL . 2b) This action is non-final. Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213.				
Disposition of Claims					
4) Claim(s) 5-14 is/are pending in the application 4a) Of the above claim(s) is/are withdrest solution is/are allowed. 5) Claim(s) is/are allowed. 6) Claim(s) 5-14 is/are rejected. 7) Claim(s) is/are objected to. 8) Claim(s) are subject to restriction and application Page 25.	awn from consideration.				
Application Papers					
9) The specification is objected to by the Examir 10) The drawing(s) filed on is/are: a) according a constant may not request that any objection to the Replacement drawing sheet(s) including the correct of the specific path or declaration is objected to by the specific path of the specific path	ccepted or b) objected to by the drawing(s) be held in abeyance. So ection is required if the drawing(s) is o	ee 37 CFR 1.85(a). bjected to. See 37 CFR 1.121(d).			
Priority under 35 U.S.C. § 119					
12) Acknowledgment is made of a claim for foreign a) All b) Some * c) None of: 1. Certified copies of the priority document copies of the priority document copies of the priority document copies of the certified copies of the priority document copies of the certified copies of the priority document copies of the certified copies of the priority document copies of the certified copies of the priority document copies of the certified copies of the priority document copies of the certified copies of the priority document copies of the pri	nts have been received. nts have been received in Applica iority documents have been receiv au (PCT Rule 17.2(a)).	tion No ved in this National Stage			
Attachment(s) 1) Notice of References Cited (PTO-892)	4) 🔲 Interview Summa	v (PTO-413)			
 Notice of References Cited (PTO-692) Notice of Draftsperson's Patent Drawing Review (PTO-948) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/0 Paper No(s)/Mail Date 	Paper No(s)/Mail I				

Art Unit: 2812

DETAILED ACTION

A request for continued examination under 37 CFR 1.114, including the fee set forth in 37 CFR 1.17(e), was filed in this application after final rejection. Since this application is eligible for continued examination under 37 CFR 1.114, and the fee set forth in 37 CFR 1.17(e) has been timely paid, the finality of the previous Office action has been withdrawn pursuant to 37 CFR 1.114. Applicant's submission filed on 3/9/2004 has been entered.

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

Claims 5-14 are rejected under 35 U.S.C. 103(a) as being unpatentable over Admitted prior art in combination with Narui (publication from Journal of Crystal Growth).

Admitted prior art teaches a method of making a semiconductor device:

Providing a GaAs substrate; growing buffer GaAs layer; successively growing multiple

AlGaAs layers with first AlGaAs (aluminum content 0.4), second AlGaAs layer

(aluminum content 0.15) and third AlGaAs layer (aluminum content 0.4) and additional

GaAs. Admitted prior art teaches when AlGaAs layer having higher Al content is grown

on AlGAs having lower Al content, multi layer AlGaAs is prone to internal footballshaped abnormal growth and such problem is illustrated in fig.3. Admitted prior art

teaches all layers are grown on flat GaAs substrate as claimed in claims 5-14(see page 1, section (0006) and fig. 3).

Admitted prior art does not teach AlGaAs layer having high aluminum content is grown at lower growth rate than the growth rate of AlGaAs layer having lower aluminum content.

Admitted prior art does not teach growing AlGaAs having higher Al content at lower growth rate than the growth rate of AlGaAs having lower Al content.

Nauri teaches successively growing GaAs layer on GaAs substrate; growing plurality of AlGaAs layers with AlGaAs with Al content 0.45, AlGaAs with Al content 0.14, AlGaAs with Al content 0.45, AlGaAs with al content 0.45, AlGaAs aluminum content 0.45, wherein Al content grater than 0.4 is grown at a growth rate of 0.16 nm/sec. It would have been obvious to one of ordinary skill in the art to modify the invention of the admitted prior art by growing AlGaAs layers with higher Al content on AlGaAs with lower Al content at lower growth rate for the benefit of obtaining smooth surface.

Response to Arguments

Applicant's arguments filed on 3/9/2004 have been fully considered but they are not persuasive. Applicant argues that Narui teaches growing AlGaAs on a ridge GaAs substrate as opposed to flat GaAs substrate as recited in instant invention. However Narui is relied on the teaching of AlGaAs with higher AlGaAs at slower growth rate 0.16 nm/sec to grow smooth AlGaAs layer and such growth results low threshold current without forming reflection coating (see conclusion section). Admitted prior art teaches

the sequence of the multilayer AlGaAs structure i.e., GaAs/AlGaAs heterostructure as instantly claimed sequence of layers and stresses that when AlGaAs with higher al content is grown on AlGaAs with lower Al content in AlGaAs multilayer structure results internal foot-ball shaped abnormal growth, which was depicted in figure.3. Modified invention, as modified by the teaching of AlGaAs having higher Al content by Narui, would give defect free AlGaAs multilayer structure, when AlGaAs grown at lower growth rate on flat GaAs substrate. Instant invention requires one only condition that AlGaAs with higher Al content is grown over flat GaAs substrate at lower growth rate. Whether the surface is flat or not, AlGaAs with higher Al content grown at lower growth rate would give smooth AlGaAs layer.

Applicant argues that the examiner turns to applicant's own disclosure for obviousness rejection. However, such argument is invalid because Admitted prior art as disclosed in background invention includes the problem of foot-ball shaped abnormal growth, when AlGaAs with higher Al content is grown on AlGaAs with lower Al content. Conclusively, modified invention of Admitted prior art would not have defects as was resulted by instant claimed process.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Savitri Mulpuri whose telephone number is 571-272-1677. The examiner can normally be reached on Mon-Fri from 7 to 4.30 p.m..

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, John Niebling, can be reached on 571-272-1679. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Savitri Mulpuri Primary Examiner Art Unit 2812